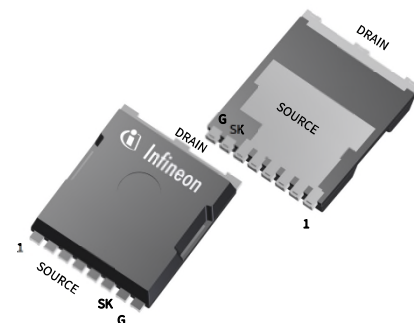


IGT60R190D1S

600V CoolGaN™ enhancement-mode Power Transistor

Features

- Enhancement mode transistor – Normally OFF switch
- Ultra fast switching
- No reverse-recovery charge
- Capable of reverse conduction
- Low gate charge, low output charge
- Superior commutation ruggedness
- Qualified for standard grade applications according to JEDEC



Standards Benefits

- Improves system efficiency
- Improves power density
- Enables higher operating frequency
- System cost reduction savings
- Reduces EMI

Gate	8
Drain	drain contact
Kelvin Source	7
Source	1,2,3,4,5,6

Applications

Consumer SMPS and high density chargers based on the half-bridge topology (half-bridge topologies for hard and soft switching such as Totem pole PFC, high frequency LLC and flyback).

For other applications: review CoolGaN™ reliability white paper and contact Infineon regional support

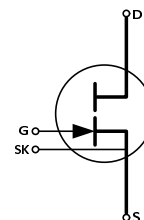


Table 1 Key Performance Parameters at $T_J = 25\text{ }^{\circ}\text{C}$

Parameter	Value	Unit
$V_{DS,max}$	600	V
$R_{DS(on),max}$	190	mΩ
$Q_{G,typ}$	3.2	nC
$I_{D,pulse}$	23	A
$Q_{oss} @ 400\text{ V}$	16	nC
Q_{rr}	0	nC



Table 2 Ordering Information

Type / Ordering Code	Package	Marking	Related links
IGT60R190D1S	PG-HSOF-8-3	60S190D1	see Appendix A



Table of Contents

Features1

Benefits1

Applications.....1

Table of Contents2

1 Maximum ratings3

2 Thermal characteristics4

3 Electrical characteristics5

4 Electrical characteristics diagrams7

5 Test Circuits13

6 Package Outlines14

7 Appendix A15

8 Revision History16

1 Maximum ratings

at $T_j = 25\text{ °C}$, unless otherwise specified.

Continuous application of maximum ratings can deteriorate transistor lifetime. For further information, contact your local Infineon sales office.

Table 3 Maximum ratings

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Drain Source Voltage ¹	$V_{DS,max}$	-	-	600	V	$V_{GS} = 0\text{ V}$
Continuous current, drain source	I_D	-	-	12.5	A	$T_C = 25\text{ °C}; T_j = T_{j,max}$
		-	-	8.0		$T_C = 100\text{ °C}; T_j = T_{j,max}$
		-	-	5.5		$T_C = 125\text{ °C}; T_j = T_{j,max}$
Pulsed current, drain source ^{2 3}	$I_{D,pulse}$	-	-	23	A	$T_C = 25\text{ °C}; I_G = 9.6\text{ mA}$; See Figure 3; Figure 5;
Pulsed current, drain source ^{3 4}	$I_{D,pulse}$	-	-	13.5	A	$T_C = 125\text{ °C}; I_G = 9.6\text{ mA}$; See Figure 4; Figure 6;
Gate current, continuous ^{3 4 5}	$I_{G,avg}$	-	-	7.7	mA	$T_j = -55\text{ °C to }150\text{ °C}$;
Gate current, pulsed ^{3 5}	$I_{G,pulse}$	-	-	770	mA	$T_j = -55\text{ °C to }150\text{ °C}$; $t_{PULSE} = 50\text{ ns}, f=100\text{ kHz}$
Gate source voltage, continuous ⁵	V_{GS}	-10	-	-	V	$T_j = -55\text{ °C to }150\text{ °C}$;
Gate source voltage, pulsed ⁵	$V_{GS,pulse}$	-25	-	-	V	$T_j = -55\text{ °C to }150\text{ °C}$; $t_{PULSE} = 50\text{ ns}, f = 100\text{ kHz}$; open drain
Power dissipation	P_{tot}	-	-	55.5	W	$T_C = 25\text{ °C}$
Operating temperature	T_j	-55	-	150	°C	
Storage temperature	T_{stg}	-55	-	150	°C	Max shelf life depends on storage conditions.
Drain-source voltage slew-rate	dV/dt			200	V/ns	

¹ All devices are 100% tested at $I_{DS} = 4.3\text{ mA}$ to assure $V_{DS} \geq 800\text{ V}$

² Limits derived from product characterization, parameter not measured during production

³ Ensure that average gate drive current, $I_{G,avg}$ is $\leq 7.7\text{ mA}$. Please see figure 27 for $I_{G,avg}$, $I_{G,pulse}$ and I_G details

⁴ Parameter is influenced by rel-requirements. Please contact the local Infineon Sales Office to get an assessment of your application.

⁵ We recommend using an advanced driving technique to optimize the device performance. Please see gate drive application note for details.

2 Thermal characteristics

Table 4 Thermal characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction-case	R_{thJC}	-	-	2.25	°C/W	
Thermal resistance, junction-ambient	R_{thJA}	-	-	62	°C/W	Device on PCB, minimum footprint
Thermal resistance, junction-ambient for SMD version	R_{thJA}	-	35	45	°C/W	Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm ² (one layer, 70μm thickness) copper area for drain connection and cooling. PCB is vertical without air stream cooling.
Reflow soldering temperature	T_{sold}	-	-	245	°C	MSL3

3 Electrical characteristics

at $T_j = 25\text{ °C}$, unless specified otherwise

Table 5 Static characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Gate threshold voltage	$V_{GS(th)}$	0.9 0.7	1.2 1.0	1.6 1.4	V	$I_{DS} = 0.96\text{ mA}$; $V_{DS} = 10\text{ V}$; $T_j = 25\text{ °C}$ $I_{DS} = 0.96\text{ mA}$; $V_{DS} = 10\text{ V}$; $T_j = 125\text{ °C}$
Drain-Source leakage current	I_{DSS}	- -	0.4 8	40 -	μA	$V_{DS} = 600\text{ V}$; $V_{GS} = 0\text{ V}$; $T_j = 25\text{ °C}$ $V_{DS} = 600\text{ V}$; $V_{GS} = 0\text{ V}$; $T_j = 150\text{ °C}$
Drain-Source leakage current at application conditions ¹	I_{DSSapp}	-	0.3	-	μA	$V_{DS} = 400\text{ V}$; $V_{GS} = 0\text{ V}$; $T_j = 125\text{ °C}$
Gate-Source leakage current	I_{GSS}	-1 -1	- -	- -	mA	$V_{DS} = 0\text{ V}$; $V_{GS} = -10\text{ V}$; $T_j = 25\text{ °C}$ $V_{DS} = 0\text{ V}$; $V_{GS} = -10\text{ V}$; $T_j = 125\text{ °C}$
Drain-Source on-state resistance	$R_{DS(on)}$	- -	0.14 0.26	0.19 -	Ω	$I_G = 9.6\text{ mA}$; $I_D = 5\text{ A}$; $T_j = 25\text{ °C}$ $I_G = 9.6\text{ mA}$; $I_D = 5\text{ A}$; $T_j = 150\text{ °C}$
Gate resistance	$R_{G,int}$	-	0.27	-	Ω	LCR impedance measurement; $f = f_{res}$

Table 6 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	-	157	-	pF	$V_{GS} = 0\text{ V}$; $V_{DS} = 400\text{ V}$; $f = 1\text{ MHz}$
Output capacitance	C_{oss}	-	28	-	pF	$V_{GS} = 0\text{ V}$; $V_{DS} = 400\text{ V}$; $f = 1\text{ MHz}$
Reverse Transfer capacitance	C_{rss}	-	0.15	-	pF	$V_{GS} = 0\text{ V}$; $V_{DS} = 400\text{ V}$; $f = 1\text{ MHz}$
Effective output capacitance, energy related ²	$C_{o(er)}$	-	32.5	-	pF	$V_{DS} = 0\text{ to }400\text{ V}$
Effective output capacitance, time related ³	$C_{o(tr)}$	-	40	-	pF	$V_{GS} = 0\text{ V}$; $V_{DS} = 0\text{ to }400\text{ V}$; $I_D = \text{const}$
Output charge	Q_{oss}	-	16	-	nC	$V_{DS} = 0\text{ to }400\text{ V}$
Turn- on delay time	$t_{d(on)}$	-	11	-	ns	see Figure 23
Turn- off delay time	$t_{d(off)}$	-	12	-	ns	see Figure 23
Rise time	t_r	-	5	-	ns	see Figure 23
Fall time	t_f	-	12	-	ns	see Figure 23

¹ Parameter represents end of use leakage in applications

² $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 400 V

³ $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 400 V

Table 7 Gate charge characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Gate charge	Q_G	-	3.2	-	nC	$I_{GS} = 0$ to 3.8 mA; $V_{DS} = 400$ V; $I_D = 5$ A

Table 8 Reverse conduction characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Source-Drain reverse voltage	V_{SD}	-	2.5	3	V	$V_{GS} = 0$ V; $I_{SD} = 5$ A
Pulsed current, reverse	$I_{S,pulse}$	-	-	23	A	$I_G = 9.6$ mA
Reverse recovery charge	Q_{rr}^1	-	0	-	nC	$I_{SD} = 5$ A, $V_{DS} = 400$ V
Reverse recovery time	t_{rr}	-	0	-	ns	
Peak reverse recovery current	I_{rrm}	-	0	-	A	

4 Electrical characteristics diagrams

at $T_j = 25\text{ °C}$, unless specified otherwise

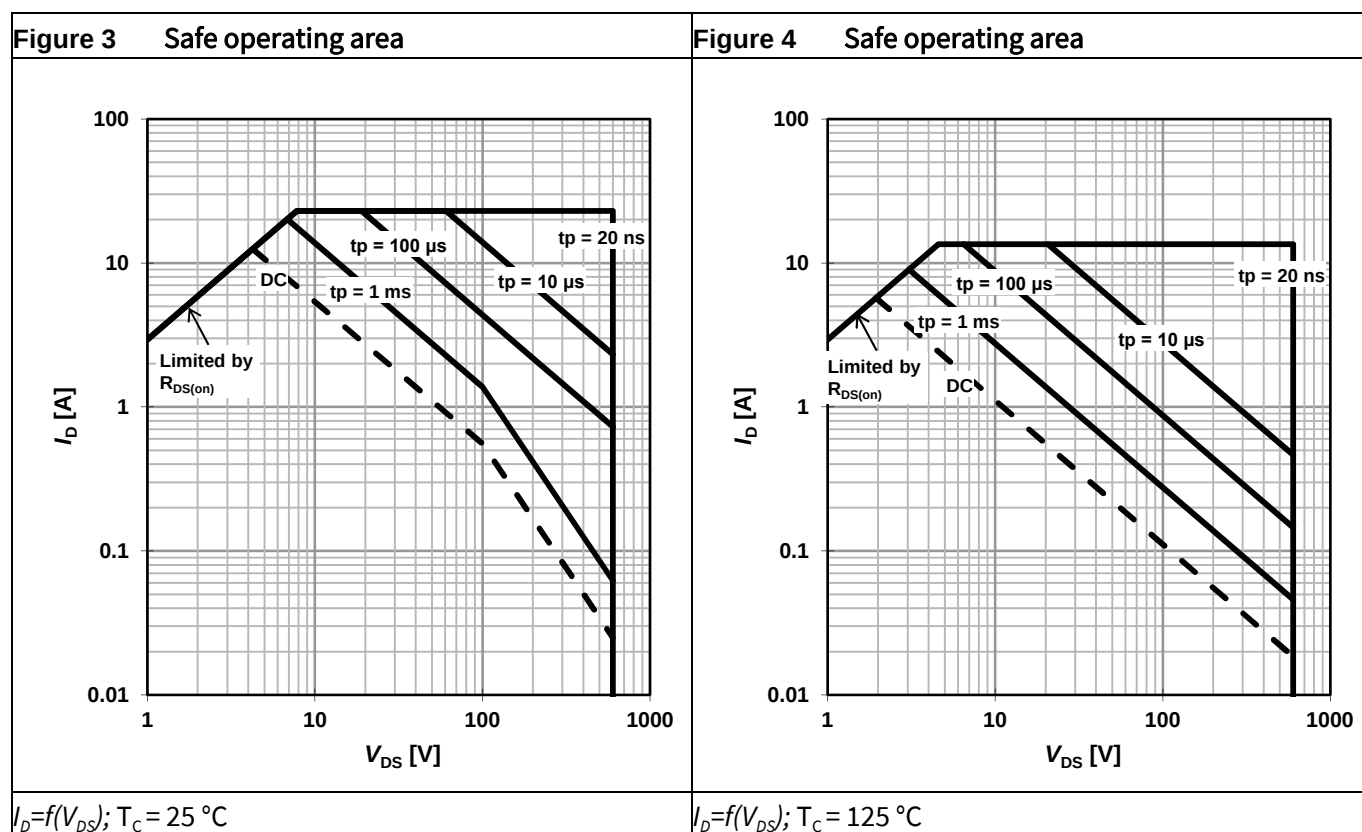
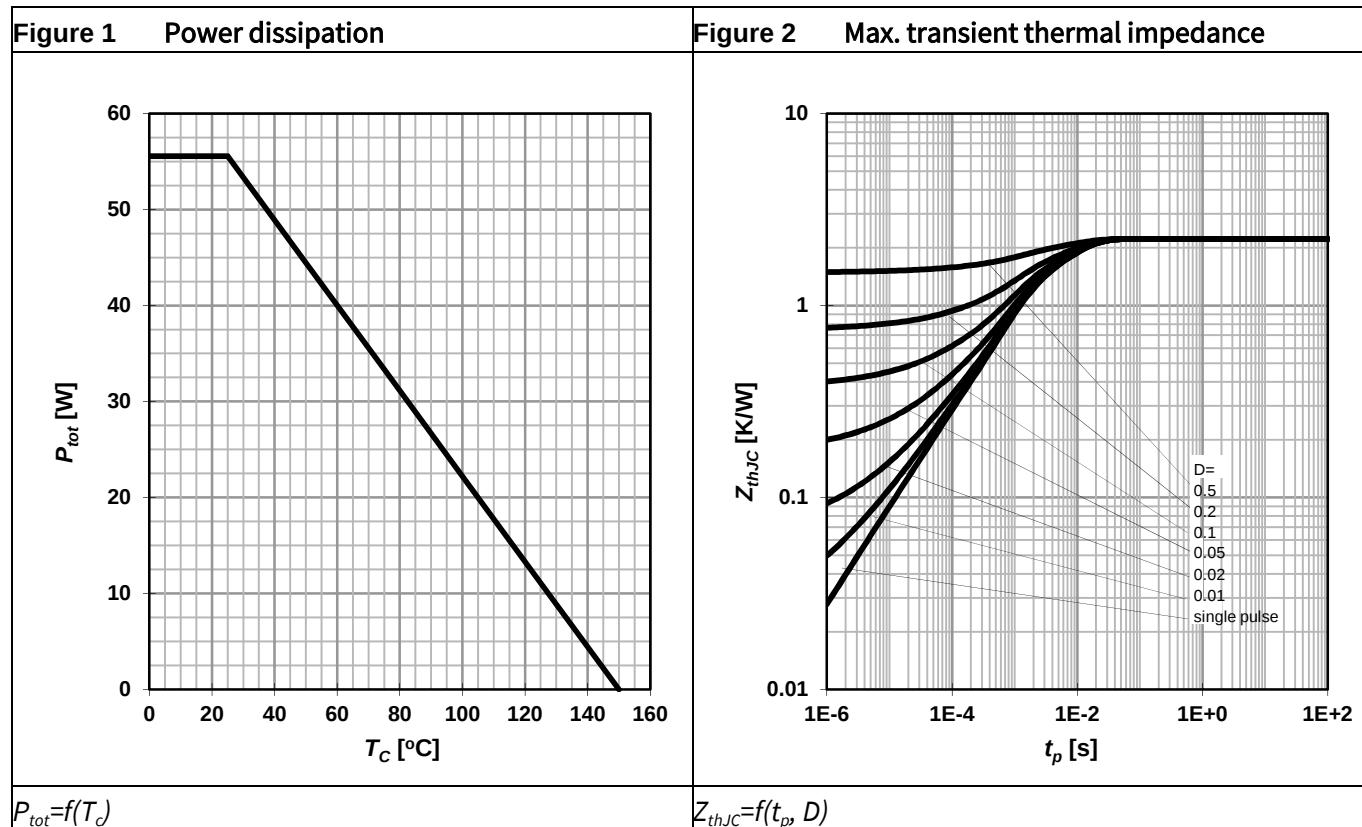
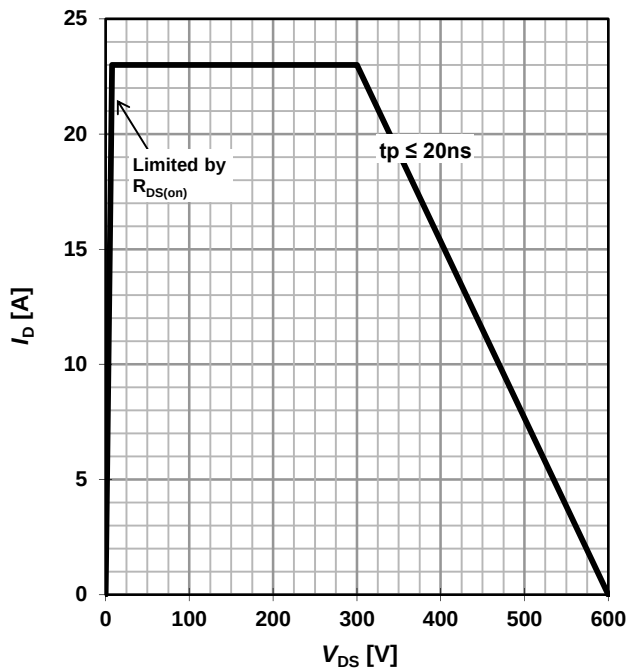
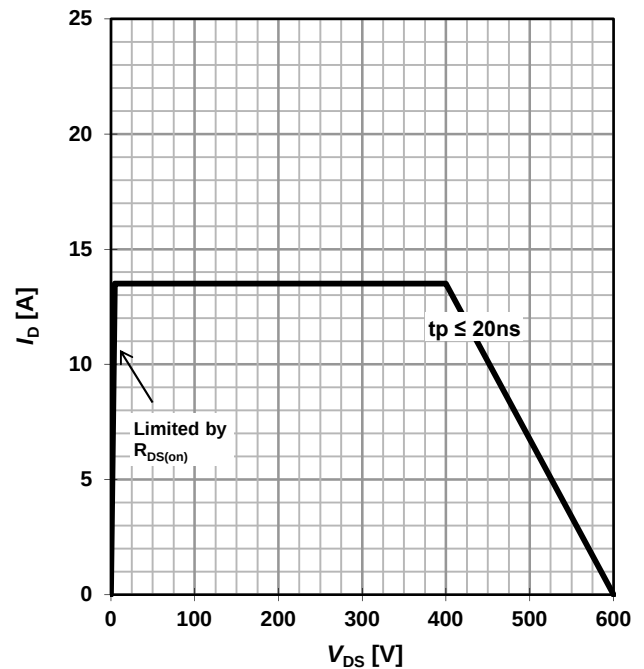


Figure 5 Repetitive safe operating area¹



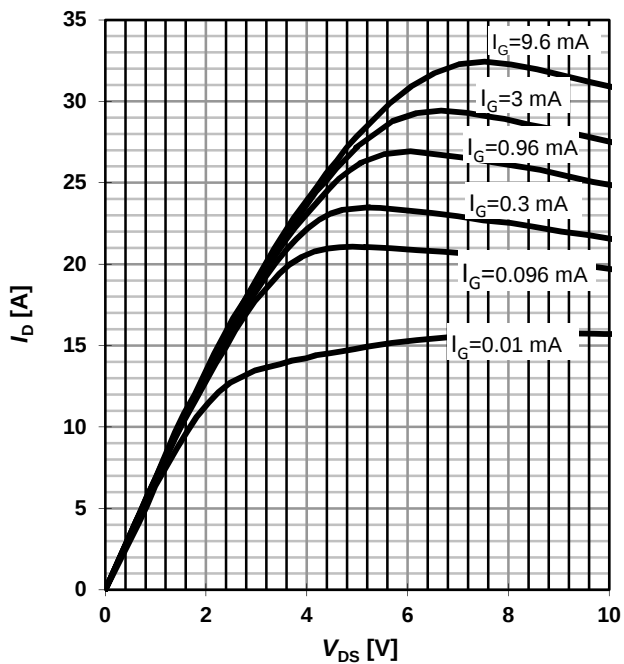
$T_c = 25\text{ °C}$; $T_j \leq 150\text{ °C}$

Figure 6 Repetitive safe operating area¹



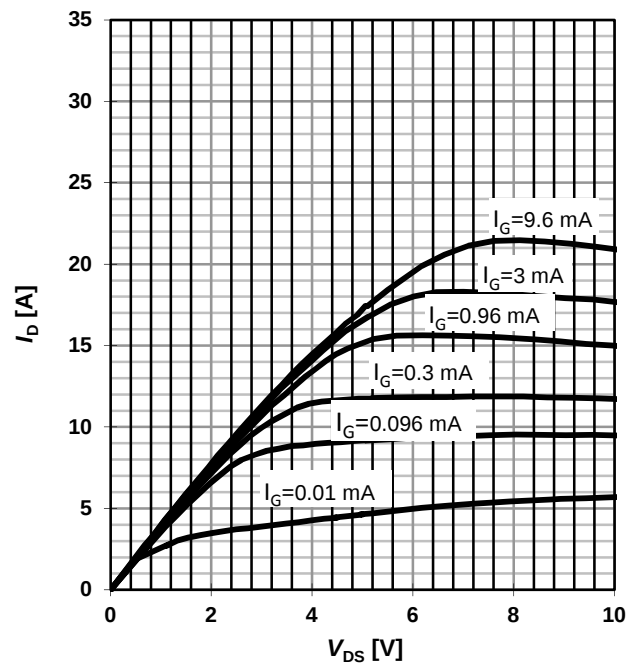
$T_c = 125\text{ °C}$; $T_j \leq 150\text{ °C}$

Figure 7 Typ. output characteristics



$I_D = f(V_{DS}, I_{GS})$; $T_j = 25\text{ °C}$

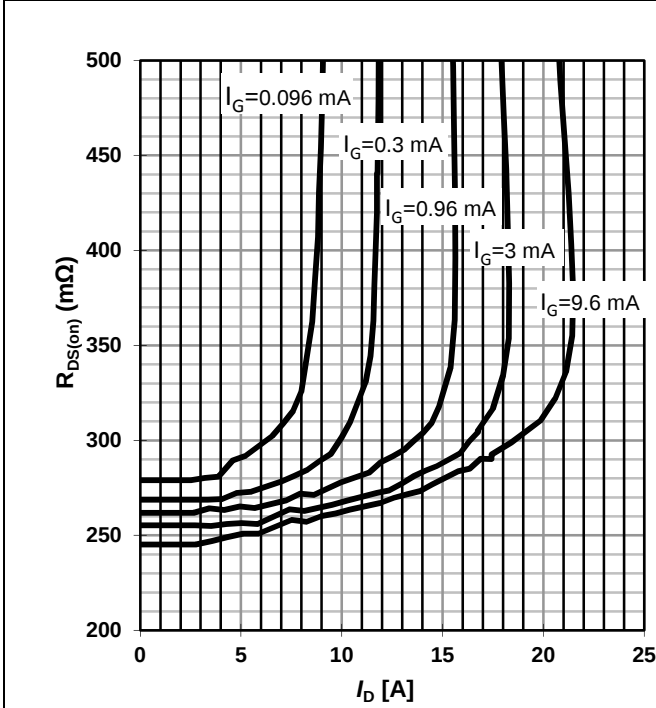
Figure 8 Typ. output characteristics



$I_D = f(V_{DS}, I_{GS})$; $T_j = 125\text{ °C}$

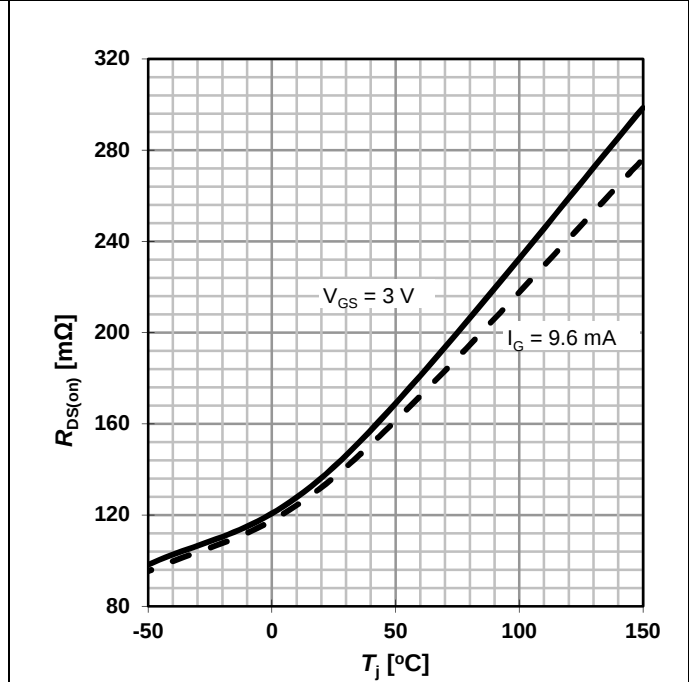
¹ Parameter is influenced by rel-requirements. This value is determined by a typical lifetime-model for consumer applications. Please contact the local Infineon Sales Office to get an assessment of your application.

Figure 9 Typ. Drain-source on-state resistance



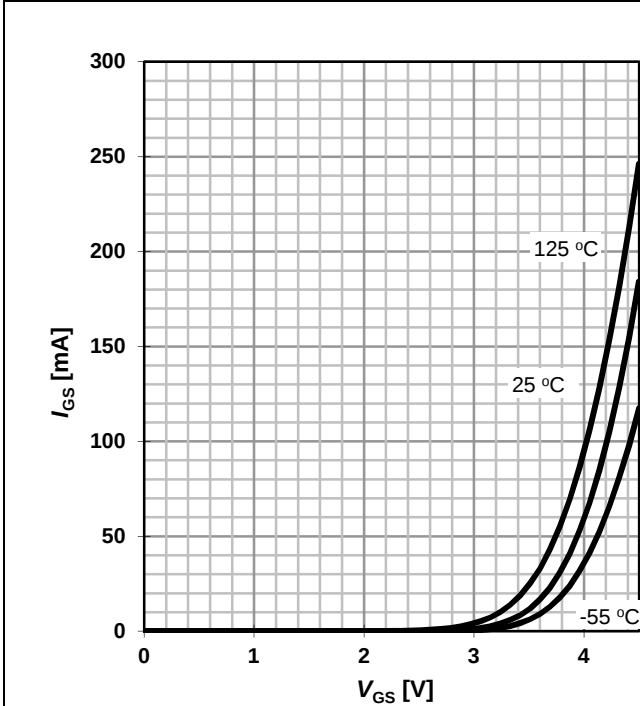
$$R_{DS(on)} = f(I_D, I_G); T_j = 125^\circ\text{C}$$

Figure 10 Drain-source on-state resistance



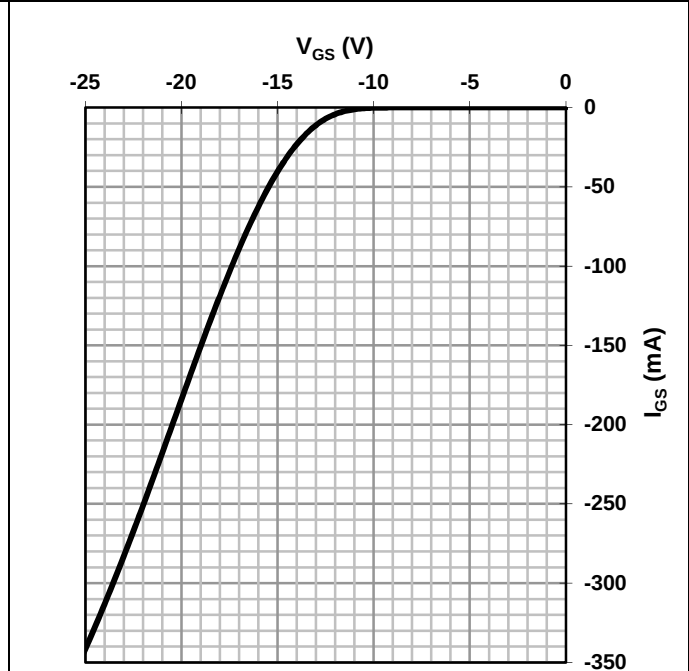
$$R_{DS(on)} = f(T_j); I_D = 5\text{ A}$$

Figure 11 Typ. gate characteristics forward



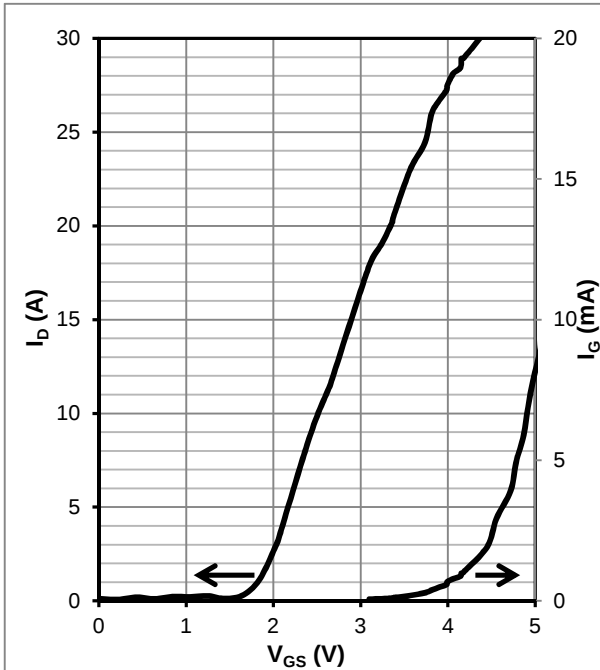
$$I_{GS} = f(V_{GS}, T_j); \text{open drain}$$

Figure 12 Typ. gate characteristics reverse



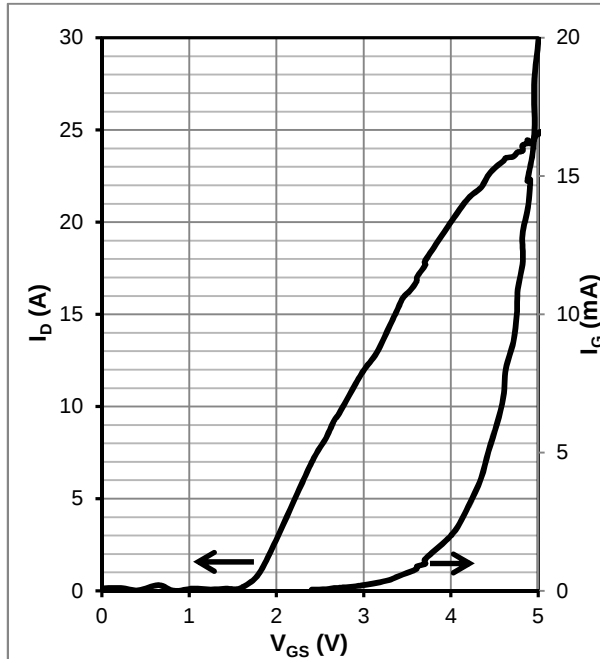
$$I_{GS} = f(V_{GS}); T_j = 25^\circ\text{C}$$

Figure 13 Typ. transfer characteristics



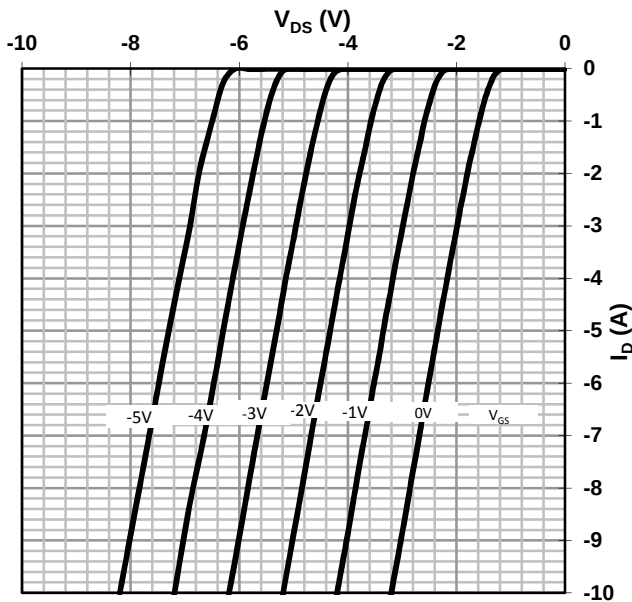
$$I_D, I_G = f(V_{GS}); V_{DS} = 8 \text{ V}; T_j = 25 \text{ }^{\circ}\text{C}$$

Figure 14 Typ. transfer characteristics



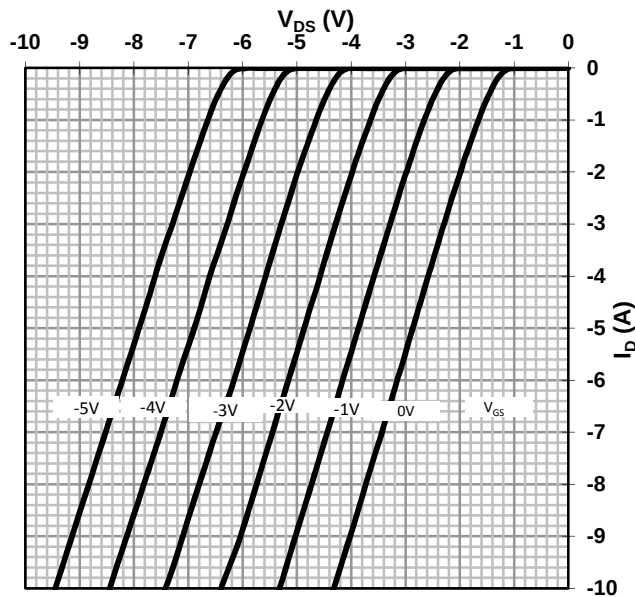
$$I_D, I_G = f(V_{GS}); V_{DS} = 8 \text{ V}; T_j = 125 \text{ }^{\circ}\text{C}$$

Figure 15 Typ. channel reverse characteristics



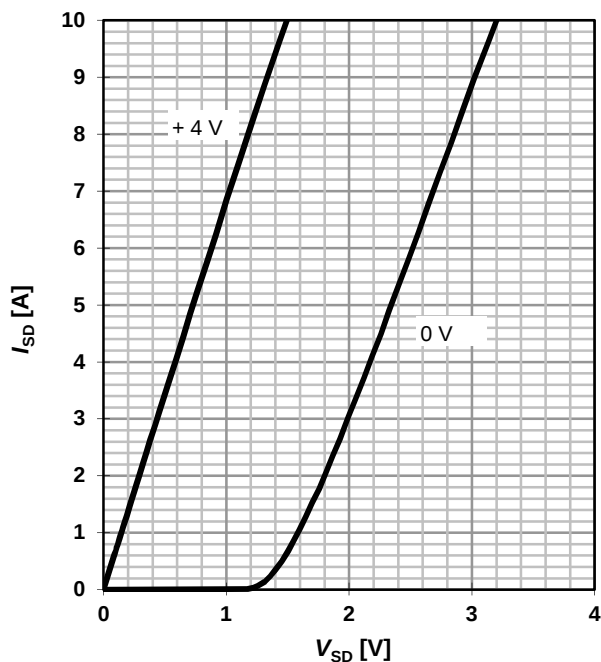
$$V_{DS} = f(I_D, V_{GS}); T_j = 25 \text{ }^{\circ}\text{C}$$

Figure 16 Typ. channel reverse characteristics



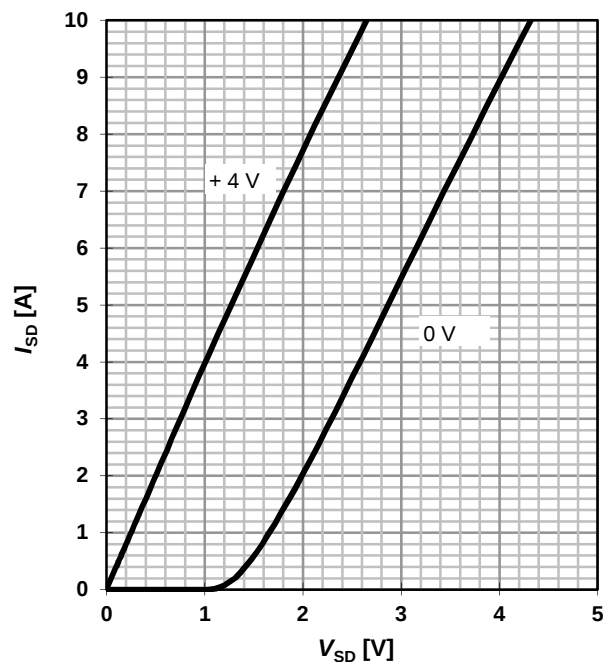
$$V_{DS} = f(I_D, V_{GS}); T_j = 125 \text{ }^{\circ}\text{C}$$

Figure 17 Typ. channel reverse characteristics



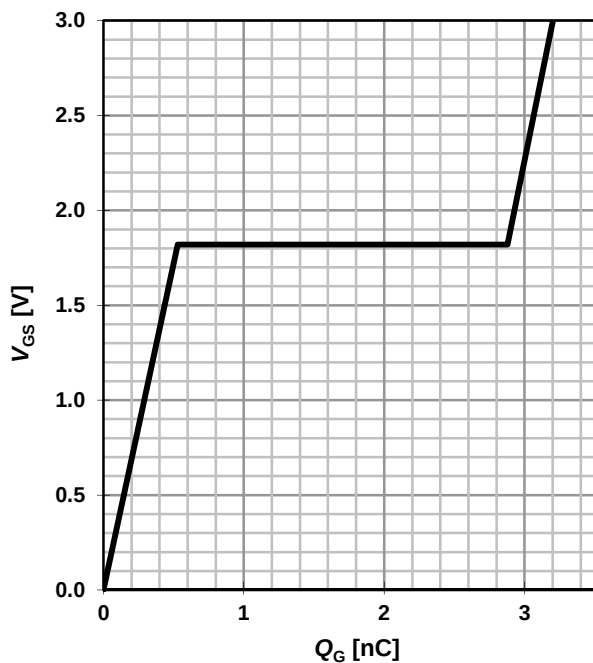
$$I_D = f(V_{DS}, V_{GS}); T_j = 25\text{ °C}$$

Figure 18 Typ. channel reverse characteristics



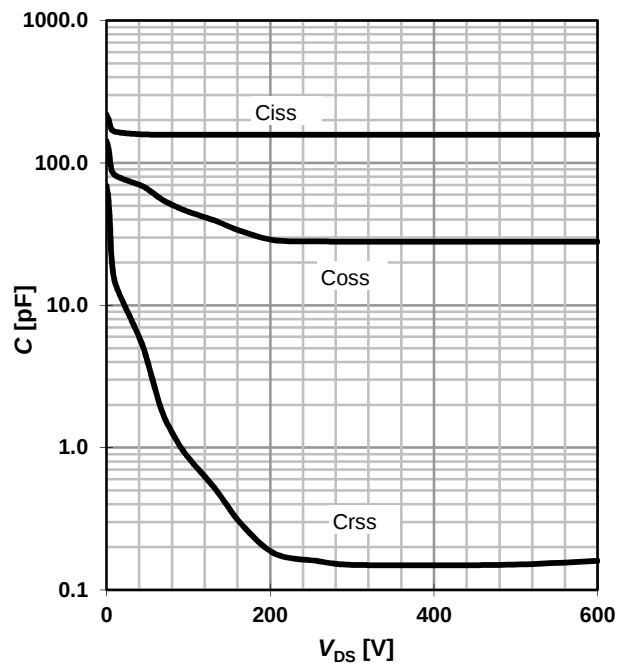
$$I_D = f(V_{DS}, V_{GS}); T_j = 125\text{ °C}$$

Figure 19 Typ. gate charge



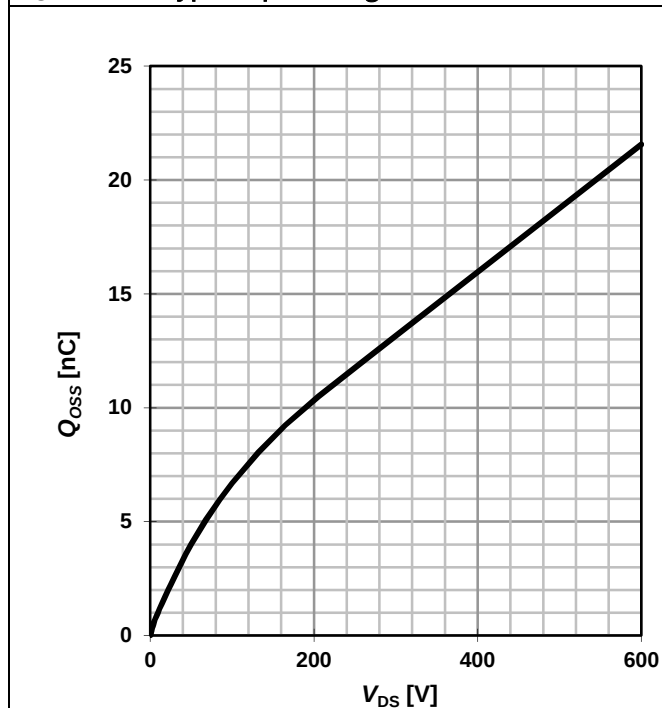
$$V_{GS} = f(Q_G); V_{DCLINK} = 400\text{ V}; I_D = 5\text{ A}$$

Figure 20 Typ. capacitances



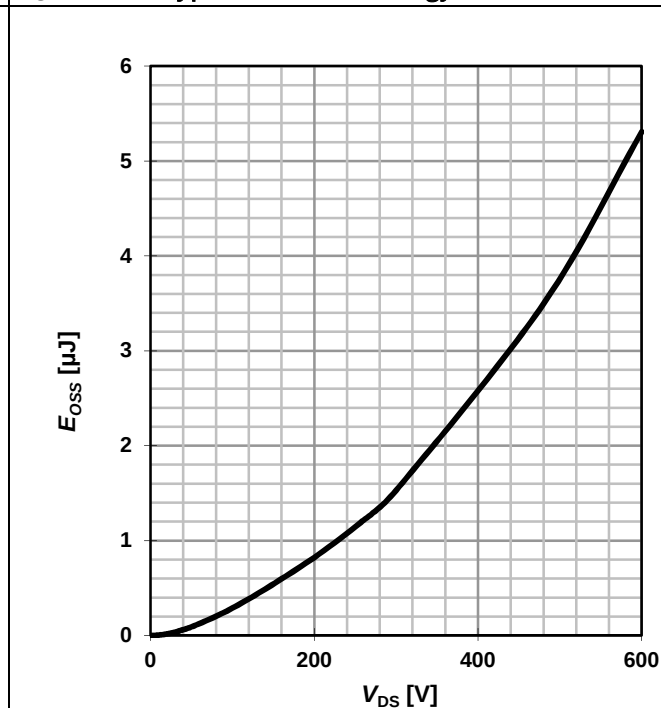
$$C_{xSS} = f(V_{DS})$$

Figure 21 Typ. output charge



$$Q_{OSS} = f(V_{DS})$$

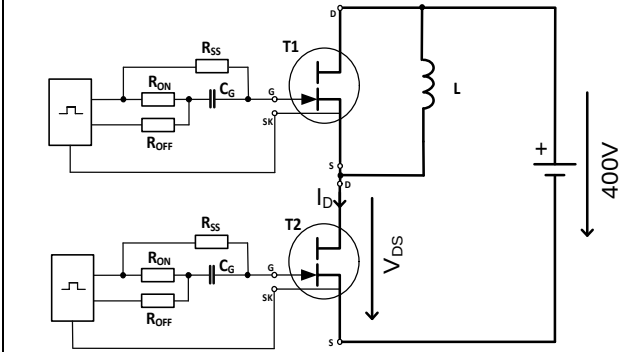
Figure 22 Typ. Coss stored Energy



$$E_{OSS} = f(V_{DS})$$

5 Test Circuits

Figure 23 Switching times with inductive load



$I_D=5\text{ A}$, $R_{ON}=15\ \Omega$; $R_{OFF}=4.7\ \Omega$; $R_{SS}=1500\ \Omega$;
 $C_G=0.68\text{ nF}$; $V_{DRV} = 12\text{ V}$

Figure 24 Switching times waveform

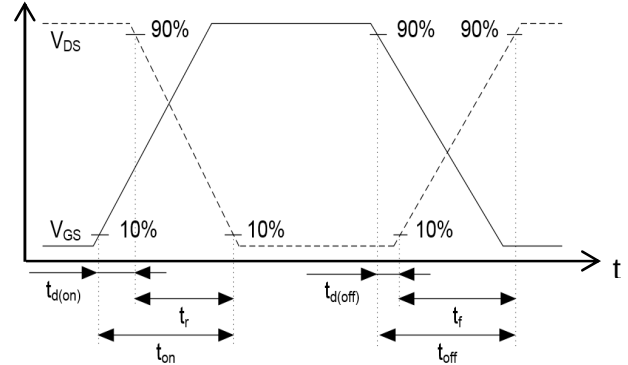
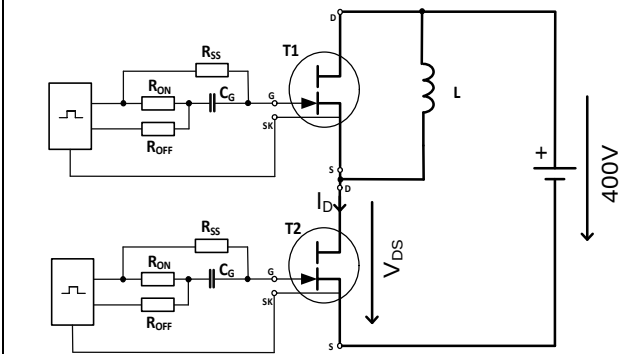
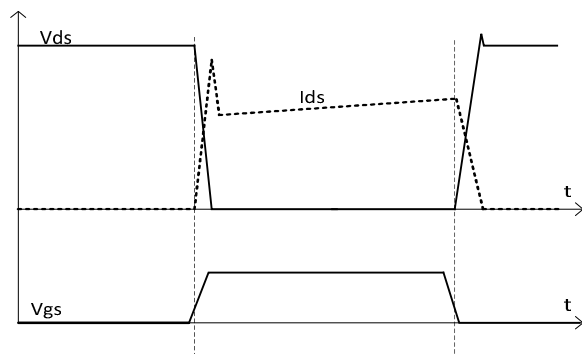


Figure 25 Reverse Channel Characteristics Test



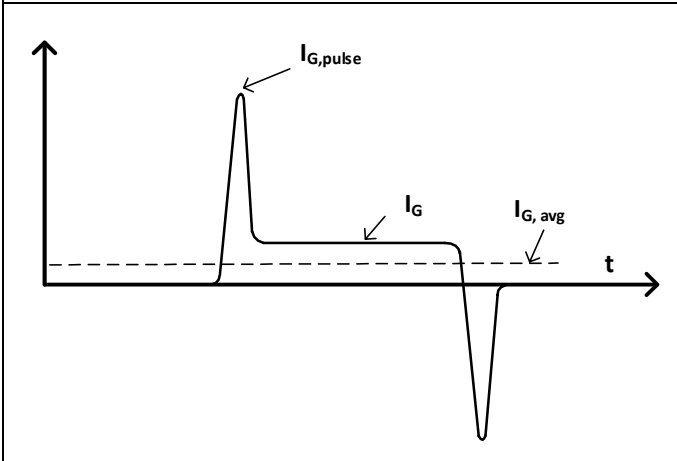
$I_D=5\text{ A}$, $R_{ON}=15\ \Omega$; $R_{OFF}=4.7\ \Omega$; $R_{SS}=1500\ \Omega$;
 $C_G=0.68\text{ nF}$; $V_{DRV} = 12\text{ V}$

Figure 26 Typical Reverse Channel Recovery



The recovery charge is Q_{oss} only, no additional Q_{rr}

Figure 27 Gate current switching waveform



6 Package Outlines

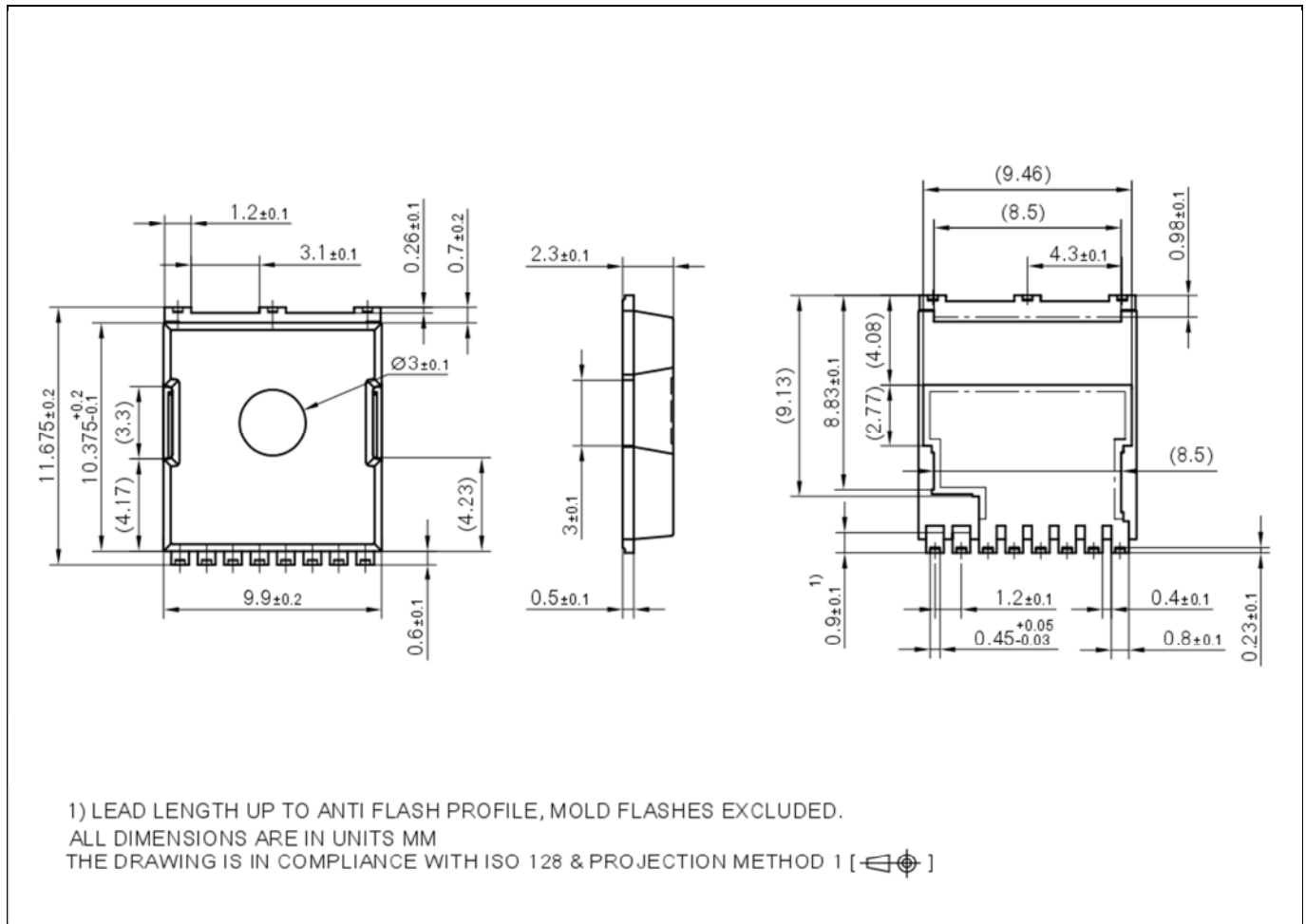


Figure 28 PG-HSOF-8-3 Package Outline, dimensions (mm)

7 Appendix A

Table 9 Related links

- IFX CoolGaN™ webpage: www.infineon.com/why-coolgan
- IFX CoolGaN™ reliability white paper: www.infineon.com/gan-reliability
- IFX CoolGaN™ gate drive application note: www.infineon.com/driving-coolgan
- IFX CoolGaN™ applications information:
 - www.infineon.com/gan-in-server-telecom
 - www.infineon.com/gan-in-wirelesscharging
 - www.infineon.com/gan-in-audio
 - www.infineon.com/gan-in-adapter-charger

8 Revision History

Major changes since the last revision

Revision	Date	Description of change
3.0	2017-04-25	Release of final version
3.1	2018-10-12	Updated application section; added Appendix A and Fig. 27; updated maximum rating table footnotes, switching times and figures.

Trademarks of Infineon Technologies AG

μHVIC™, μIPM™, μPFC™, AU-ConvertIR™, AURIX™, C166™, CanPAK™, CIPOS™, CIPURSE™, CoolDP™, CoolGaN™, COOLiR™, CoolMOS™, CoolSET™, CoolSiC™, DAVE™, DI-POL™, DirectFET™, DrBlade™, EasyPIM™, EconoBRIDGE™, EconoDUAL™, EconoPACK™, EconoPIM™, EiceDRIVER™, eupec™, FCOS™, GaNpowIR™, HEXFET™, HITFET™, HybridPACK™, iMOTION™, IRAM™, ISOFACE™, IsoPACK™, LEDrivr™, LITIX™, MIPAQ™, ModSTACK™, my-d™, NovalithIC™, OPTIGA™, OptiMOS™, ORIGA™, PowIRaudio™, PowIRstage™, PrimePACK™, PrimeSTACK™, PROFET™, PRO-SIL™, RASIC™, REAL3™, SmartLEWIS™, SOLID FLASH™, SPOC™, StrongIRFET™, SupIRBuck™, TEMPFET™, TRENCHSTOP™, TriCore™, UHVIC™, XHP™, XMC™

Trademarks updated November 2015

Other Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

Edition 2018-10-12

Published by

Infineon Technologies AG
81726 München, Germany

© 2018 Infineon Technologies AG.
All Rights Reserved.

Do you have a question about this document?

Email: erratum@infineon.com

Document reference

ifx1

IMPORTANT NOTICE

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (www.infineon.com).

WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.

Данный компонент на территории Российской Федерации

Вы можете приобрести в компании MosChip.

Для оперативного оформления запроса Вам необходимо перейти по данной ссылке:

<http://moschip.ru/get-element>

Вы можете разместить у нас заказ для любого Вашего проекта, будь то серийное производство или разработка единичного прибора.

В нашем ассортименте представлены ведущие мировые производители активных и пассивных электронных компонентов.

Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

Офис по работе с юридическими лицами:

105318, г.Москва, ул.Щербаковская д.3, офис 1107, 1118, ДЦ «Щербаковский»

Телефон: +7 495 668-12-70 (многоканальный)

Факс: +7 495 668-12-70 (доб.304)

E-mail: info@moschip.ru

Skype отдела продаж:

moschip.ru

moschip.ru_4

moschip.ru_6

moschip.ru_9